Docket No.: P2001,0176

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hereby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage as First Class Mail in an envelope addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on the dare indicated below.

By: / / / /

Date: October 1, 2003

N THE WNITED STATES PATENT AND TRADEMARK OFFICE

Applic. No.

10/657,841

Applicant

Johannes Baur et al. September 9, 2003

Art Unit

Filed

to be assigned

Examiner

to be assigned

Docket No.

P2001,0176

Customer No.:

24131

INFORMATION DISCLOSURE STATEMENT

Hon. Commissioner for Patents

Sir:

In accordance with 37 C.F.R. 1.98 copies of the following patents and/or publications are submitted herewith:

Japanese Patent Abstract JP 61 110 476 (Yanagihara), dated May 28, 1986;

J. Zhang et al.: "Precise microfabrication of wide band gap semiconductors (SiC and GaN) by VUV-UV multiwavelength laser ablation", *Applied Surface Science, Vol.* 127-129, 1998, pp. 793-799;

W. N. Carr: "Photometric Figures Of Merit For Semiconductor Luminescent Sources Operating in Spontaneous Mode", *Infrared Physics*, 1966, Vol. 6, pp. 1-19.

Respectfully submitted,

For Applicants

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Date: October 1, 2003

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